

Contents

Preface	xix
Figure credits	xxi
1 Why photomultipliers?	1
1.1 Aspects of light detection	2
1.1.1 Introduction	2
1.1.2 Brief history of PMTs	3
1.1.3 The statistical case for PMTs	4
1.1.4 DC detection with a PMT	7
1.1.5 Detection of single photoelectrons	9
1.1.6 Detection of multi-photoelectron signals	10
1.1.7 Summary of PMT key attributes	11
1.2 Other light detectors	12
1.2.1 Silicon PIN diodes	12
1.2.2 APDs	12
1.2.3 SiPMs	14
1.2.4 Summary of silicon key attributes	16
1.2.5 Visible-light photon counters	17
1.2.6 CCDs	17
1.2.7 Hybrid photodetectors and APDs	17
1.3 Pulse height resolution	18
1.4 Position resolution	21
1.5 Signal-to-background considerations	21
2 Photocathodes	24
2.1 Introduction	25
2.1.1 Solid angles	26
2.2 Fundamentals of photosensitivity	27
2.2.1 The electromagnetic spectrum	27
2.2.2 Photoelectric phenomena	28
2.2.3 Photoelectron energy distribution	29
2.3 Spectral radiation and photometric units	30
2.3.1 Spectral radiant energy	30
2.3.2 Photometric units and standards	30
2.3.3 Filter measurements	33
2.3.4 Calibration laboratories and absolute radiation standards	35
2.3.5 Trap detectors	35

2.4	Optical properties of end window photocathodes	37
2.4.1	Refraction in dielectrics	37
2.4.2	Reflection from dielectrics	40
2.4.3	Photocathode optical properties	42
2.4.4	Techniques for measuring photocathode reflectance	43
2.4.5	Limits to reliable measurement	44
2.4.6	Determination of transmission and absorptance	45
2.5	Spectral sensitivity of photocathodes	50
2.5.1	Three foremost photocathodes	50
2.5.2	Photocathode response to scintillator light	52
2.5.3	Solar blind photocathodes	54
2.5.4	Infrared photocathodes	56
2.5.5	High-temperature photocathodes	58
2.6	Photocathode geometries	58
2.6.1	Range of end window PMTs	58
2.6.2	Range of side window PMTs	60
2.6.3	Window materials	61
2.7	Photocathode resistivity	62
2.8	QE temperature dependence	65
2.8.1	Laboratory and commercial applications, $-30\text{ }^{\circ}\text{C}$ to $+60\text{ }^{\circ}\text{C}$	65
2.8.2	Ultra-low temperature performance, $-273\text{ }^{\circ}\text{C}$ to $-30\text{ }^{\circ}\text{C}$	67
2.8.3	High-temperature operation, $+60\text{ }^{\circ}\text{C}$ to $+200\text{ }^{\circ}\text{C}$	68
2.9	Dark count temperature sensitivity	69
2.10	Critical photocathode properties	69
2.10.1	Photocathode uniformity	69
2.10.2	Ionizing radiation	72
2.11	Summary of factors affecting photocathode response	73
3	The optical interface to PMTs	78
3.1	Introduction	79
3.2	Light attenuation and reflection coefficients	80
3.2.1	Light attenuation length, γ	80
3.2.2	Reflectance coefficients, ρ	81
3.2.3	Optical coupling of scintillators	83
3.3	Point light source	84
3.4	Interfacing to small volume scintillators	86
3.4.1	Interfacing to scintillators of high Z	88
3.4.2	Interfacing to scintillators of low Z	90
3.5	Light concentrators	90
3.5.1	Light concentrators: Theory	90
3.5.2	Light concentrators: Winston cone	91
3.5.3	Integrating spheres	92

3.6	Scintillators with diffuse reflecting walls	93
3.7	Light output from scintillator slabs	95
3.7.1	Escape cones	95
3.8	Light guides	97
3.8.1	Hollow guides with specular reflecting walls	98
3.8.2	Solid guides based on TIR	98
3.8.3	Adiabatic light guides	99
3.9	Light detection efficiency for scintillators	101
3.9.1	PMT viewing a large-area face	101
3.9.2	PMT viewing small-area face	103
3.9.3	Photoelectron yield for scintillation counters	105
3.9.4	Monte Carlo simulations	107
3.10	Uniformity of response in large-area detectors	107
3.11	WLS light guides	109
3.12	Optical fibres	110
3.12.1	Application of fibres to scintillating tiles	112
3.12.2	Use of fibres with large-area plastic scintillator slabs	114
3.13	Techniques for enhancing light detection	115
3.13.1	Anti-reflection coatings	115
3.13.2	Sandblasting	115
3.13.3	Theory of light recycling	117
3.13.4	Internal prismatic window	119
3.13.5	External optical enhancement devices	120
3.13.6	WLS coatings	123
4	Statistical processes	128
4.1	Introduction	129
4.1.1	Single- and multi-photon light sources	129
4.2	Binomial, Poisson, and normal distributions	131
4.3	Mean and variance	132
4.4	Folding of probability density functions	136
4.5	Moments	139
4.5.1	Moments about the origin	139
4.5.2	Central moments	140
4.5.3	Factorial moments	141
4.5.4	Exercise in photon counting	142
4.6	Probability generating functions	145
4.7	Sum of chance integers	147
4.8	Moment generating functions	149
4.9	Folding with probability generating functions	151
4.10	Cascaded processes	153
4.10.1	Generalized two-stage cascading	153
4.10.2	Light detection statistics	154
4.10.3	Multiplier dispersion	155
4.10.4	Pdf at the k^{th} dynode	157

4.11	Shot noise in DC detection	161
4.12	Noise in multi-photon excitation	163
4.13	Continuous SER distributions	166
4.14	Multi-photoelectron pdfs	169
4.15	MPHD for an empirical SER	173
4.16	Arrival time statistics	175
4.16.1	Exponential time signatures	175
4.16.2	First two moments for R fixed	177
4.16.3	First two moments for R randomized	178
4.17	Determination of afterpulse rates	180
4.17.1	Afterpulses: Method I	181
4.17.2	Afterpulses: Method II	182
4.18	Scaling and dead time	183
4.18.1	Interval distribution	184
4.18.2	The p-fold time interval	184
4.19	Dead time	188
4.19.1	Sources of dead time	188
4.19.2	Counting losses attributed to dead time	190
4.19.3	Type I, paralysable counters	190
4.19.4	Type II, non-paralysable counters	191
4.19.5	Dead time and variance	193
4.19.6	Determination of dead time	194
4.19.7	Suppressing correlated signals	197
5	Secondary emission and gain	202
5.1	Introduction	203
5.2	Gain generation with discrete dynodes	204
5.3	Single-photoelectron noise spectra	208
5.4	Secondary-electron emission	210
5.4.1	Classical description	210
5.4.2	Secondary-electron yield	214
5.4.3	Theory and measurement	215
5.4.4	Secondary-electron statistics	216
5.4.5	Temperature dependence of gain	218
5.5	Sources of undersized signals	219
5.5.1	Inelastic scattering	219
5.5.2	Gain non-uniformity	222
5.5.3	Events initiated by d_1	224
5.5.4	Other sources of undersized signals	224
5.6	Discrete dynodes	225
5.6.1	Venetian blind dynodes and skipping	226
5.6.2	Coarse mesh dynodes	229

5.6.3	Fine-mesh dynodes	230
5.6.4	Metal-channel dynodes	230
5.6.5	Linear and circular focussed dynodes	232
5.6.6	Box-and-grid dynodes	234
5.6.7	Transmission dynodes	234
5.7	Continuous multipliers	237
5.7.1	CEMs	237
5.7.2	MCPs	239
5.7.3	Gain–voltage considerations in MCPs	240
5.8	Multiplier and PMT gain measurement	241
5.8.1	Measurement of G : First method	242
5.8.2	Measurement of G : Second method	243
5.8.3	Measurement of G : Third method	243
5.8.4	Measurement of $\langle g \rangle$: First method	245
5.8.5	Measurement of $\langle g \rangle$: Second method	247
5.8.6	Measurement of $\langle g \rangle$: Third method	248
5.8.7	Measurement of $\langle g \rangle$: Fourth method	249
5.9	Quick determination of $\langle g \rangle$	249
5.9.1	Quick determination of $\langle g \rangle$: First method	251
5.9.2	Quick determination of $\langle g \rangle$: Second method	251
5.10	Gain–voltage characteristics	252
5.11	Conclusions	253
6	PMT background	257
6.1	Introduction	258
6.2	Dark counts and dark current	259
6.2.1	Subdivision of a dark count distribution	260
6.3	Reconciliation of dark current and dark counts	261
6.4	S/B in DC applications	264
6.5	Light generation within a PMT	265
6.6	Sources of background	266
6.6.1	Region A: Undersized pulses	267
6.6.2	Regions B and C: Single- and multi-electron background	267
6.6.3	Dependence on temperature	267
6.6.4	Ionizing radiation	269
6.7	Gamma background	271
6.7.1	Radionuclides within PMTs	274
6.8	Cosmic ray muons	276
6.8.1	Cerenkov emission in a PMT window	277
6.8.2	PMT orientation	278
6.9	Means for reducing background	279
6.10	Summary	279

7 Measurement of low light flux	282
7.1 The physical nature of light detection	283
7.1.1 Noise and background	283
7.2 Measurement modes	284
7.2.1 Photon counting	284
7.2.2 DC detection	284
7.2.3 Shot noise power detection	286
7.3 Detection methods and weighting	288
7.3.1 Detection techniques	289
7.4 Difference between two count rates	291
7.4.1 Efficient time allocation	291
7.5 Signal recovery instrumentation	293
7.5.1 Boxcar integrators	293
7.5.2 Lock-in detection	294
7.5.3 Synchronous signal averaging	296
7.5.4 Signal recovery simulation	297
7.5.5 Subdividing time intervals	298
7.5.6 Upper and lower thresholds	300
7.5.7 Signal magnitudes: Photon counting	301
7.5.8 Signal magnitudes: DC detection	302
7.5.9 Excess noise factor	303
7.5.10 Ratemeter operation	304
7.6 PMT selection criteria	306
7.6.1 Optimal gain for DC detection	307
7.6.2 Optimal HV for photon counting	308
7.6.3 MCA plateau characteristic	311
7.6.4 Critical PMT parameters	312
7.6.5 Discriminator threshold	316
7.7 Methods involving DMMs and electrometers	317
7.7.1 Measurements with a DMM	317
7.7.2 Electrometers	318
7.7.3 Voltage dividers	319
8 Timing with PMTs	321
8.1 Electron motion in electric fields	322
8.1.1 Introduction	322
8.1.2 Electron motion in a uniform electric field	328
8.1.3 Electron motion in non-uniform electric fields	329
8.1.4 Laws of motion applied to PMTs	330
8.1.5 Spot size	331
8.2 Evolution of fast linear focussed PMTs	333
8.2.1 The PMT front end	333
8.2.2 Contribution to time dispersion from dynodes	337

8.2.3	Transit-time effects at the PMT back end	339
8.2.4	Ultra-fast PMTs	341
8.3	PMT output signal	341
8.3.1	Signature of the anode signal	341
8.3.2	Simulation of photoelectron time intervals	343
8.3.3	Simulation of multiplier noise and jitter	345
8.3.4	Oscilloscope traces for NaI(Tl) signals	347
8.3.5	Scintillator rise and fall time	350
8.4	Timing	351
8.4.1	Single-electron time response	351
8.4.2	Transit time, T	353
8.4.3	Effect of amplitude fluctuations on jitter	356
8.4.4	Effect of charge sensitivity on jitter	357
8.4.5	Contribution to jitter from noise	357
8.5	Zero crossing and CF methods	358
8.5.1	Charge threshold for triggering	361
8.5.2	CF technique	363
8.6	Measurement schematics	365
8.7	Multiple statistical sources	369
8.7.1	Single-photoelectron output signatures	369
8.7.2	Photoelectron timing variance	370
8.8	Photon arrival statistics	373
8.9	Timing measurements	376
8.10	Timing summary	378
9	Linear performance	383
9.1	Introduction	384
9.1.1	Modes of operation	385
9.1.2	Rate effect	387
9.1.3	Causes of non-linearity	387
9.1.4	Dynode materials	387
9.2	Dynamic range	388
9.2.1	Achievable dynamic range: Analogue	388
9.2.2	Achievable dynamic range: Pulse mode	389
9.2.3	Onset of DC non-linearity	391
9.2.4	Onset of pulsed non-linearity	392
9.2.5	Bootstrap method	394
9.3	Theoretical considerations	394
9.4	Advanced linearity investigations	398
9.4.1	Single-step method	399
9.4.2	Ratiometric method	402
9.4.3	Shot noise method	403
9.5	Correcting non-linearity	404
9.6	Non-linearity in inorganic crystals	405
9.7	Summary	407

10 Collection and counting efficiency	410
10.1 Introduction	411
10.2 Lost photoelectrons	412
10.2.1 Front end design	412
10.2.2 Optimal operating conditions	413
10.3 Collection and counting efficiency	414
10.3.1 Collection efficiency, F	414
10.3.2 Anode detection efficiency, ϵ	415
10.4 Measurement techniques	415
10.4.1 Attenuation using filters	415
10.4.2 Count rate determination	416
10.5 Determination of F	418
10.5.1 Based on d_1 gain	418
10.5.2 Shot noise	422
10.5.3 The bi-photonic field	424
10.5.4 Calibrated lamp	425
10.5.5 Cerenkov light source	425
10.5.6 Use of a power meter	426
10.5.7 Calibrated silicon photodiodes	427
10.6 Summary and conclusions	428
11 Signal-induced background	431
11.1 Introduction	432
11.2 Timing instrumentation	432
11.2.1 Amplifier discriminators	432
11.2.2 Configurations for afterpulse measurements	433
11.2.3 Stop–start instrumentation	434
11.3 Prepulses and late pulses	435
11.4 Detector response function	439
11.5 Afterpulses	440
11.5.1 Early measurements	440
11.5.2 Theory of afterpulse generation	442
11.5.3 Contributions to understanding afterpulses	445
11.5.4 Afterpulses in photon counting	447
11.5.5 Exposure of PMTs to helium	448
11.6 Exposure to bright light	449
11.6.1 Settling time: Medium term	449
11.6.2 Settling time: Long term	449
11.7 Summary and conclusions	452
12 Environmental considerations	455
12.1 Introduction	456
12.1.1 Performance in weak magnetic fields	456
12.1.2 Performance in high magnetic fields	458

12.1.3	The effect of electric fields	458
12.1.4	PMT enclosures, modules, and housings	461
12.1.5	Housings for scintillators	463
12.1.6	Light leaks and electric fields	464
12.2	Operation in harsh environments	465
12.2.1	Shock and vibration	465
12.2.2	Operation at high temperature	467
13	Voltage dividers	471
13.1	Introduction	472
13.2	Gain–voltage relationships	473
13.2.1	Resistive dividers	473
13.2.2	Dividers with zener diodes	475
13.3	Analysis of resistive dividers	477
13.4	Resistive divider operation	482
13.5	Inclusion of zener diodes	484
13.6	Active voltage dividers	488
13.6.1	Fully active N-type analysis	489
13.6.2	Fully active P-type analysis	490
13.6.3	Fully active circuits	493
13.6.4	Gain linearity	495
13.6.5	Partially active circuits	496
13.6.6	Cockcroft–Walton dividers	497
13.7	Voltage dividers for pulsed operation	499
13.7.1	Decoupling capacitors	499
13.7.2	Pin connections	501
13.7.3	Decoupling options	501
13.7.4	Switch-on transients	502
13.8	Methods and circuits	503
13.8.1	Power supply polarity and ripple	503
13.8.2	Wiring options	506
13.8.3	Dynode signals	507
13.8.4	Shorting dynodes	509
13.8.5	Single cable dividers	510
13.8.6	Gain adjustment	511
13.8.7	Equivalent circuit at high frequencies	511
13.8.8	Wiring practice	512
13.9	Gating	515
13.9.1	Electro-optical and mechanical gating	517
13.9.2	HV switching	517
13.9.3	Photocathode gating	518
13.9.4	Dynode gating	518
13.9.5	Focus-electrode gating	521
13.9.6	Circuit realization	522
13.9.7	Pulse generators and shielding	522

14 Electronics for PMTs	527
14.1 Introduction	528
14.2 Charge output transducers	530
14.3 The role of a preamplifier	531
14.3.1 Interfacing and signal transmission	532
14.3.2 Grounding and shielding	534
14.4 Circuit protection and limiting	534
14.5 Modular electronics	535
14.6 PMT equivalent circuit	538
14.6.1 PMT signal bandwidth	541
14.7 Multiple PMT outputs	543
14.8 Passive circuit analysis	544
14.8.1 Anode DC-coupled R C network	545
14.8.2 Anode AC-coupled R C network	547
14.9 Signal-shaping preamplifiers	549
14.9.1 Charge-sensitive preamplifiers	550
14.9.2 Commercial charge-sensitive amplifiers	552
14.9.3 Pole-zero cancellation	554
14.9.4 Preamplifier calibration	555
14.10 Signal-shaping main amplifiers	555
14.10.1 Signal-shaping theory	555
14.10.2 Detector noise	559
14.10.3 Modular detection equipment	561
14.11 Fast amplifiers	562
14.11.1 Discrete-component amplifiers	562
14.11.2 Amplifiers incorporating microwave transistors	564
14.11.3 Fast bench-top and NIM preamplifiers	566
14.11.4 Voltage- and current-feedback OP-AMPS	566
14.11.5 Transimpedance amplifier circuits using CFAs	569
14.11.6 Logarithmic amplifiers	571
14.12 Pulsed-light sources	572
14.13 Optimizing PMT performance	573
14.14 DSP	574
Appendix A PMT output distributions	581
A.1 General considerations	581
A.2 Schematics and methods for measuring distributions	583
A.3 Integral pulse height distributions	583
A.4 Differential pulse height distributions	583
A.5 Plateau characteristic	584
A.6 Changing variables	585
A.7 Transformations of an analytic function	588
A.8 Transformation of experimental data	591

A.9	Single-photoelectron distributions	592
A.10	Probability distributions in high temperature NaI(Tl) applications	597
A.11	Conclusions	600
Appendix B Light emission by the Cerenkov effect		603
B.1	Introduction	603
B.2	Threshold conditions for the Compton effect	604
B.3	Formulations for Cerenkov emission	606
B.4	The yield from MIPs	608
Appendix C Abbreviations		611
Index		615